ON Semiconductor

Is Now



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Self-Protected Low Side Driver with In-Rush Current Management

The NCV8411 is a three terminal protected Low–Side Smart Discrete FET. The protection features include Delta Thermal Shutdown, overcurrent, overtemperature, ESD and integrated Drain to Gate clamping for over voltage protection. The device also offers fault indication via the gate pin. This device is suitable for harsh automotive environments.

Features

- Short Circuit Protection with In-Rush Current Management
- Delta Thermal Shutdown
- Thermal Shutdown with Automatic Restart
- Over Voltage Protection
- Integrated Clamp for Over Voltage Protection and Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

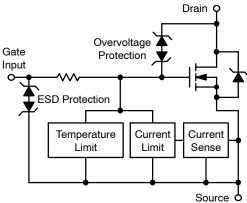


Figure 1. Block Diagram

1



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V _{DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX (Limited)
42 V	23 mΩ @ 10 V	45 A



CASE 369C STYLE 2

MARKING DIAGRAM

1 = Gate	1	AYWW	h
2 = Drain	2 🗖	NCV	
3 = Source	3 🗁	8411G	μ

A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV8411DTRKG	DPAK (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

Table 1. MAXIMUM RATINGS

Rating	Symbol	Value (min)	Unit
Drain-to-Source Voltage Internally Clamped	V _{DSS}	42	V
Drain-to-Gate Voltage Internally Clamped	V_{DG}	42	V
Gate-to-Source Voltage	V _{GS}	±14	V
Drain Current - Continuous	I _D	Internally Lin	nited
Total Power Dissipation @ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2)	P _D	1.3 2.7	W
Thermal Resistance Junction-to-Case Junction-to-Ambient (Note 1) Junction-to-Ambient (Note 2)	R _{thJC} R _{thJA} R _{thJA}	0.65 95 45	°C/W
Single Pulse Inductive Load Switching Energy (Note 3) $(L = 120 \text{ mH}, T_{J(start)} = 150^{\circ}\text{C})$	E _{AS}	600	mJ
Load Dump Voltage (VGS = 0 and 10 V, RG = 2 Ω , RL = 3 Ω) (Note 4)	U _S *	55	V
Operating Junction Temperature	T _J	-40 to 150	°C
Storage Temperature	T _{storage}	-55 to 150	°C
ESD CHARACTERISTICS (Note 3)			-
Electro-Static Discharge Capability Human Body Model (HBM)	ESD	4	kV

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Mounted onto a 2" square FR4 board (100 sq mm, 1 oz. Cu, steady state)
 Mounted onto a 2" square FR4 board (645 sq mm, 1 oz. Cu, steady state)
- 3. Not tested in production.
- Load Dump Test B (with centralized load dump suppression) according to ISO16750–2 standard. Guaranteed by design. Not tested in production. Passed Class C according to ISO16750–1.

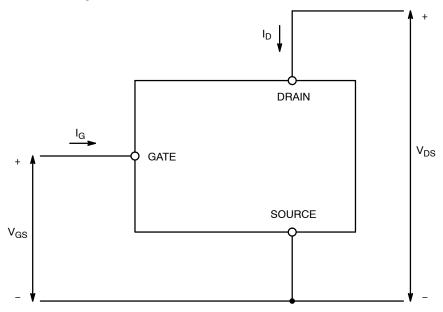


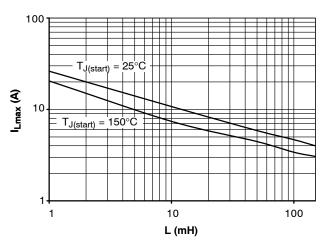
Figure 2. Voltage and Current Convention

Table 2. ELECTRICAL CHARACTERISTICS (T $_{J}$ = $25^{\circ}C$ unless otherwise noted)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Clamped	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	V _{(BR)DSS}	42	46	50	V
Breakdown Voltage	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A,}$ $T_J = 150^{\circ}\text{C (Note 5)}$		42	44	50	
Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V	I _{DSS}	-	1.5	5	μΑ
	V _{DS} = 32 V, V _{GS} = 0 V, T _J = 150°C (Note 5)		-	5.5	-	
Gate Input Current	$V_{GS} = 5 \text{ V}, V_{DS} = 0 \text{ V}$	I_{GSS}	-	50	100	μΑ
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1.2 \text{ mA}$	V _{GS(th)}	1.0	1.8	2.5	V
Threshold Temperature Coefficient	$V_{GS} = V_{DS}$, $I_D = 1.2 \text{ mA (Note 5)}$		-	5	-	mV/°C
Static Drain-to-Source	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}, T_J = 25^{\circ}\text{C}$	R _{DS(ON)}	-	23	29	mΩ
On Resistance	V _{GS} = 10 V, I _D = 5 A, T _J = 150°C (Note 5)		-	43	55	
	$V_{GS} = 5 \text{ V}, I_D = 5 \text{ A}, T_J = 25^{\circ}\text{C}$		-	28	34	1
	V _{GS} = 5 V, I _D = 5 A, T _J = 150°C (Note 5)		-	50	60	
Source Drain Forward On Voltage	$I_S = 5 A, V_{GS} = 0 V$	V_{SD}	-	0.8	1.1	V
SWITCHING CHARACTERISTICS (No	ote 5)					
Turn-On Time (10% V_{GS} to 90% I_D)	$V_{GS} = 0 \text{ V to 5 V},$	t _{ON}	-	29	50	μs
Turn-Off Time (90% V_{GS} to 10% I_{D})	$V_{DS} = 12 \text{ V}, I_{D} = 1 \text{ A}$	t _{OFF}	-	53	150	1
Turn-On Time (10% V_{GS} to 90% I_D)	$V_{GS} = 0 \text{ V to } 10 \text{ V},$	t _{ON}	-	14	25	
Turn-Off Time (90% V_{GS} to 10% I_{D})	$V_{DS} = 12 \text{ V}, I_D = 1 \text{ A}$	t _{OFF}	ı	80	180	
Slew Rate On (80% V_{DS} to 50% V_{DS})	$V_{GS} = 0 \text{ V to } 10 \text{ V},$	$-dV_{DS}/dt_{ON}$	-	1.52	2.5	V/μs
Slew Rate Off (50% V_{DS} to 80% V_{DS})	$V_{DD} = 12 \text{ V}, R_L = 4.7 \Omega$	dV _{DS} /dt _{OFF}	-	0.71	0.85	
SELF PROTECTION CHARACTERIST	rics					
Current Limit	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	I _{LIM}	29	33	40	Α
	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V},$ $T_J = 150^{\circ}\text{C (Note 5)}$		27	31	37	
	V _{GS} = 10 V, V _{DS} = 10 V (Note 5)		23	34	46	
	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V},$ $T_{J} = 150^{\circ}\text{C (Note 5)}$		23	33	46	
Temperature Limit (Turn-Off)	V _{GS} = 5 V (Note 5)	T _{LIM(OFF)}	150	170	185	°C
Thermal Hysteresis		$\Delta T_{LIM(ON)}$	-	10	_	1
Temperature Limit (Turn-Off)	V _{GS} = 10 V (Note 5)	T _{LIM(OFF)}	150	180	200	
Thermal Hysteresis		$\Delta T_{LIM(ON)}$	_	10	_	
GATE INPUT CHARACTERISTICS (N	ote 5)					
Device ON Gate Input Current –	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}, I_D = 1 \text{ A}$	I _{GON}	-	50	100	μΑ
Normal Operation	V _{GS} = 10 V, V _{DS} = 10 V, I _D = 1 A		200	318	500	
Device ON Gate Input Current –	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}, I_D = 0 \text{ A}$	I_{GTL}	_	633	900	
Thermal Limit	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}, I_D = 0 \text{ A}$		_	1470	2000	
Device ON Gate Input Current –	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$	I _{GCL}	-	245	600	
Current Limit	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$		-	1121	1500	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

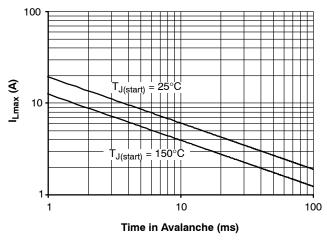
5. Not tested in production.



10000
T_{J(start)} = 25°C
T_{J(start)} = 150°C
100
L (mH)

Figure 3. Single Pulse Maximum Switch-off Current vs. Load Inductance

Figure 4. Single Pulse Maximum Switching Energy vs. Load Inductance



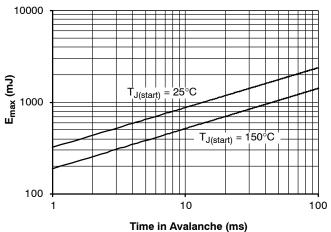
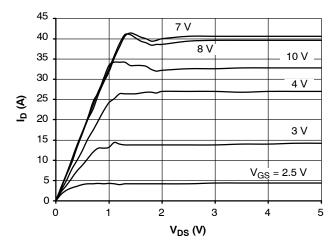


Figure 5. Single Pulse Maximum Inductive Switch-off Current vs. Time in Avalanche

Figure 6. Single Pulse Maximum Inductive Switching Energy vs. Time in Avalanche



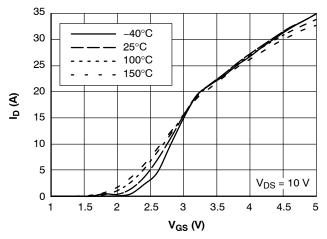


Figure 7. On-state Output Characteristics at 25°C

Figure 8. Transfer Characteristics

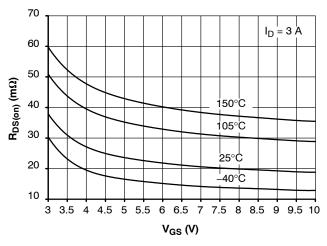


Figure 9. R_{DS(on)} vs. Gate-Source Voltage

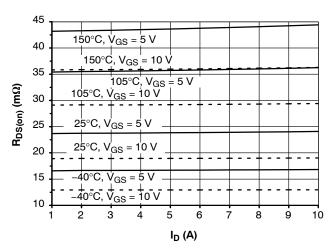


Figure 10. R_{DS(on)} vs. Drain Current

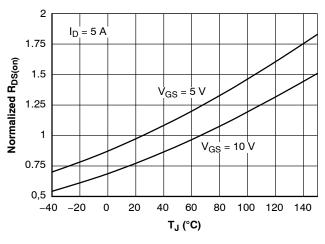


Figure 11. Normalized R_{DS(on)} vs. Temperature

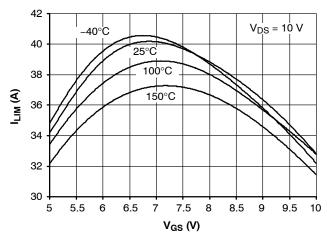


Figure 12. Current Limit vs. Gate-Source Voltage

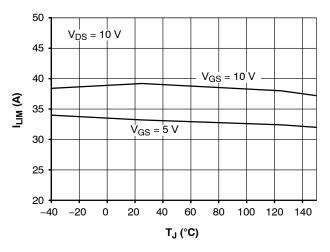


Figure 13. Current Limit vs. Junction Temperature

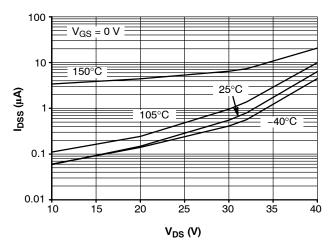


Figure 14. Drain-to-Source Leakage Current

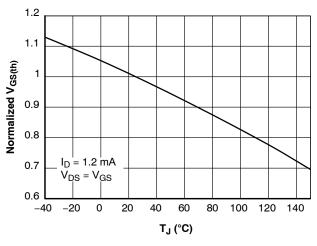


Figure 15. Normalized Threshold Voltage vs. Temperature

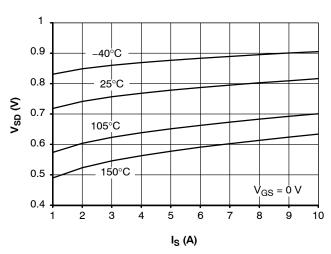


Figure 16. Source-Drain Diode Forward Characteristics

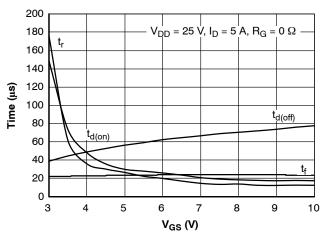


Figure 17. Resistive Load Switching Time vs.
Gate-Source Voltage

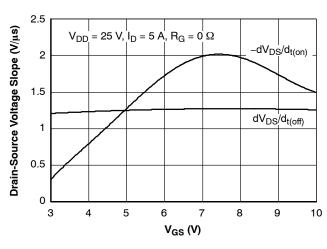


Figure 18. Resistive Load Switching Drain-Source Voltage Slope vs. Gate-Source Voltage

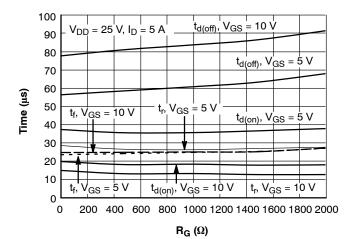


Figure 19. Resistive Load Switching Time vs.
Gate Resistance

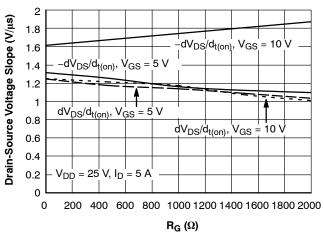


Figure 20. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

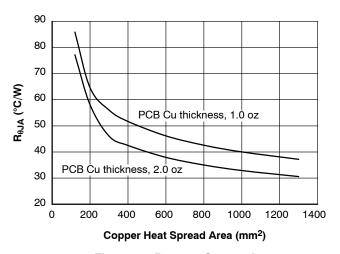


Figure 21. $R_{\theta JA}$ vs. Copper Area

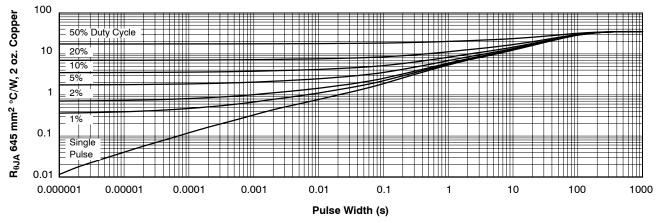


Figure 22. Transient Thermal Resistance

APPLICATION INFORMATION

Circuit Protection Features

The NCV8411 has three main protections. Current Limit, Thermal Shutdown and Delta Thermal Shutdown. These protections establish robustness of the NCV8411.

Current Limit and Short Circuit Protection

The NCV8411 has current sense element. In the event that the drain current reaches designed current limit level, integrated Current Limit protection establishes its constant level.

Delta Thermal Shutdown

Delta Thermal Shutdown (DTSD) Protection increases higher reliability of the NCV8411. DTSD consist of two independent temperature sensors – cold and hot sensors. The

NCV8411 establishes a slow junction temperature rise by sensing the difference between the hot and cold sensors. ON/OFF output cycling is designed with hysteresis that results in a controlled saw tooth temperature profile (Figure 23). The die temperature slowly rises (DTSD) until the absolute temperature shutdown (TSD) is reached around 175°C.

Thermal Shutdown with Automatic Restart

Internal Thermal Shutdown (TSD) circuitry is provided to protect the NCV8411 in the event that the maximum junction temperature is exceeded. When activated at typically 175°C, the NCV8411 turns off. This feature is provided to prevent failures from accidental overheating.

TEST CIRCUITS AND WAVEFORMS

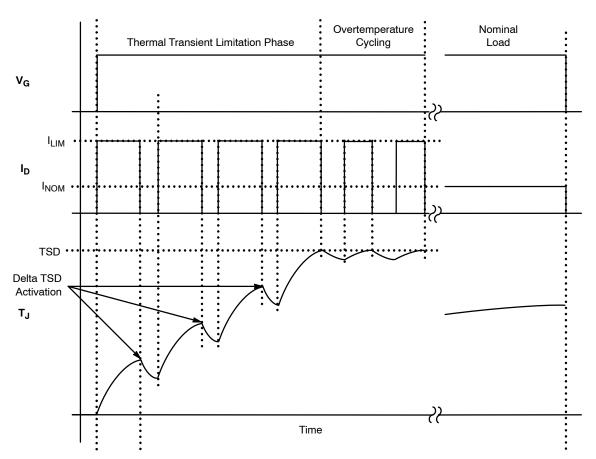


Figure 23. Overload Protection Behavior

TEST CIRCUITS AND WAVEFORMS

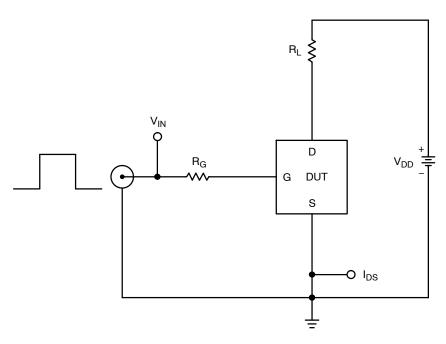


Figure 24. Resistive Load Switching Test Circuit

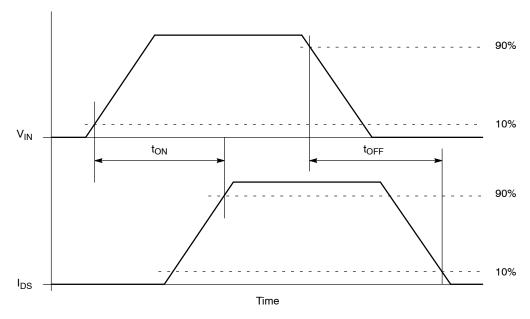


Figure 25. Resistive Load Switching Waveforms

TEST CIRCUITS AND WAVEFORMS

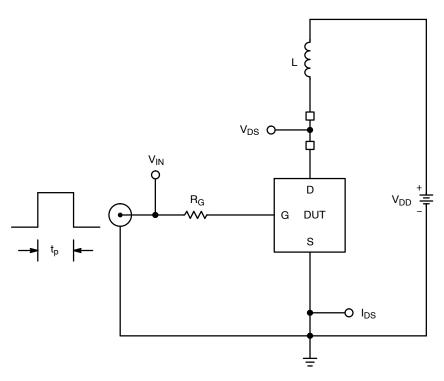


Figure 26. Inductive Load Switching Test Circuit

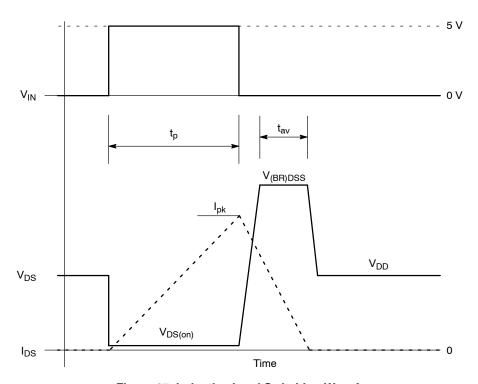
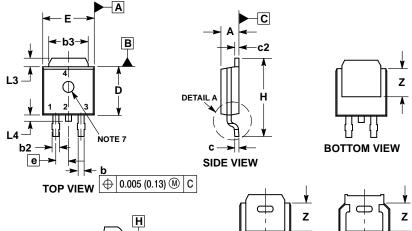
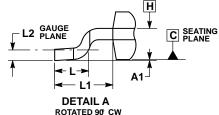


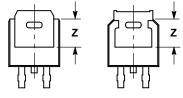
Figure 27. Inductive Load Switching Waveform

DATE 21 JUL 2015

DPAK (SINGLE GAUGE) CASE 369C ISSUE F SCALE 1:1 Α



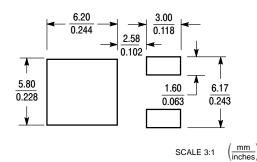




BOTTOM VIEW ALTERNATE CONSTRUCTIONS

STYLE 1: PIN 1. BASE 2. COLLECT 3. EMITTER 4. COLLECT	3. SOUI	N 2. CATH RCE 3. ANO	HODE 2. ANODE DE 3. GATE	STYLE 5: PIN 1. GATE 2. ANODE 3. CATHODE 4. ANODE
	TYLE 7:	STYLE 8:	STYLE 9:	STYLE 10:
	PIN 1. GATE	PIN 1. N/C	PIN 1. ANODE	PIN 1. CATHODE
	2. COLLECTOR	2. CATHODE	2. CATHODE	2. ANODE
	3. EMITTER	3. ANODE	3. RESISTOR ADJUST	3. CATHODE
	4. COLLECTOR	4. CATHODE	4. CATHODE	4. ANODE

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- IOTES. 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES. 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-

- MENSIONS b3, L3 and Z.

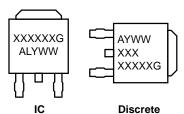
 Jimensions b And E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

 MENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	REF	2.90	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

GENERIC MARKING DIAGRAM*



XXXXXX = Device Code

= Assembly Location Α L = Wafer Lot Υ = Year

WW = Work Week G = Pb-Free Package

DOCUMENT NUMBER:	98AON10527D	Electronic versions are uncontrolle	•	
STATUS:	ON SEMICONDUCTOR STANDARD	accessed directly from the Document versions are uncontrolled except		
NEW STANDARD:	REF TO JEDEC TO-252	"CONTROLLED COPY" in red.		
DESCRIPTION:	DPAK SINGLE GAUGE SURFACE MOU	NT	PAGE 1 OF 2	

^{*}This information is generic. Please refer to device data sheet for actual part marking.



DOCUMENT	NUMBER:
98AON10527	7D

PAGE 2 OF 2

ISSUE	REVISION	DATE	
0	RELEASED FOR PRODUCTION. REQ. BY L. GAN	24 SEP 2001	
Α	A ADDED STYLE 8. REQ. BY S. ALLEN. B ADDED STYLE 9. REQ. BY D. WARNER.		
В			
С	ADDED STYLE 10. REQ. BY S. ALLEN.	09 JUN 2009	
D	RELABELED DRAWING TO JEDEC STANDARDS. ADDED SIDE VIEW DETAIL A. CORRECTED MARKING INFORMATION. REQ. BY D. TRUHITTE.	29 JUN 2010	
E	ADDED ALTERNATE CONSTRUCTION BOTTOM VIEW. MODIFIED DIMENSIONS b2 AND L1. CORRECTED MARKING DIAGRAM FOR DISCRETE. REQ. BY I. CAMBALIZA.	06 FEB 2014	
F	ADDED SECOND ALTERNATE CONSTRUCTION BOTTOM VIEW. REQ. BY K. MUSTAFA.	21 JUL 2015	

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